

SCDS236B-DECEMBER 2006-REVISED APRIL 2009

DUAL SUPPLY, LOW ON-STATE RESISTANCE SPST CMOS ANALOG SWITCHES

FEATURES

- ±1-V to ±6-V Dual-Supply Operation
 - Specified ON-State Resistance:
 - 25 Ω Max With ±5-V Supply
 - 35 Ω Max With ±3.3-V Supply
 - 47 Ω Max With ±1.8-V Supply
- Specified Low OFF-Leakage Currents:
 - 5 nA at 25°C
 - 10 nA at 85°C

- Specified Low ON-Leakage Currents:
 - 5 nA at 25°C
 - 10 nA at 85°C
- Low Charge Injection: 13 pC (±5-V Supply)
- Fast Switching Speed: t_{ON} = 85 ns, t_{OFF} = 50 ns (±5-V Supply)
- Break-Before-Make Operation (t_{ON} > t_{OFF})
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2500-V Human-Body Model (A114-F)
 - 1000-V Charged-Device Model (C101-C)
 - 250-V Machine Model (A115-A)

DESCRIPTION/ORDERING INFORMATION

The TS12A4516/TS12A4517 are single pole/single throw (SPST), low-voltage, dual-supply CMOS analog switches, with very low switch ON-state resistance. The TS12A4516 is normally open (NO). The TS12A4517 is normally closed (NC).

These CMOS switches can operate continuously with a dual supplies between ± 1 V and ± 6 V [(2 V < (V₊ - V₋) < 12 V]. Each switch can handle rail-to-rail analog signals. The OFF-leakage current maximum is only 5 nA at 25°C or 10 nA at 85°C.

For pin-compatible parts for use with single supply, see the TS12A4514/TS12A4515.

ORDERING INFORMATION

T _A	PACKAG	E ⁽¹⁾⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
	SOIC – D	Reel of 1500	TS12A4516D	YD516		
	30IC - D	Reel of 2500	TS12A4516DR	10510		
–40°C to 85°C	SOP (SOT-23) – DBV	Reel of 3000	TS12A4516DBVR	9CL_		
-40 C 10 85 C		Reel of 1500	TS12A4517D	VDE17		
	SOIC – D	Reel of 2500	TS12A4517DR	- YD517		
	SOP (SOT-23) – DBV	Reel of 3000	TS12A4517DBVR	9CM_		

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

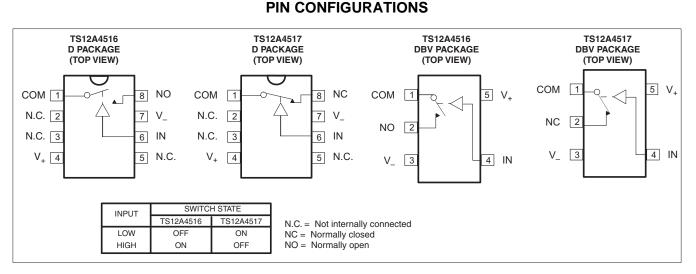
(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



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Absolute Minimum and Maximum Ratings⁽¹⁾⁽²⁾

voltages referenced to 0 V

			MIN	MAX	UNIT
V+	Supply voltage range		-0.3	13	V
V _{NC} V _{NO} V _{COM}	Analog voltage range ⁽³⁾	V0.3	V ₊ + 0.3	V	
V _{IN}	Logic input range	V0.3	V ₊ + 0.3	V	
	Continuous current into any terminal		±20	mA	
	Peak current, NO or COM (pulsed at 1 ms, 1		±30	mA	
	ESD per method 3015.7			>2000	V
	Continuous power dissipation ($T_{A} = 70^{\circ}C$)	8-pin SOIC (derate 5.88 mW/°C above 70°C)		471	m\//
	Continuous power dissipation $(T_A = 70 \text{ C})$	5-pin SOT23-5 (derate 7.1 mW/°C above 70°C)		571	mW
T _A	Operating temperature range	-40	85	°C	
T _{stg}	Storage temperature range	-65	150	°C	
	Lead temperature (soldering, 10 s)			300	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum

(3) Voltages exceeding V₊ or GND on any signal terminal are clamped by internal diodes. Limit forward-diode current to maximum current rating.



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Electrical Characteristics for ±5-V Supply⁽¹⁾

 V_{+} = 4.5 V to 5.5 V, V_{-} = -4.5 V to -5.5 V, T_{A} = -40°C to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	TA	MIN TYP ⁽²⁾	MAX	UNIT
Analog Switch						
Analog signal range	V _{COM} , V _{NO} , V _{NC}			V_	V+	V
		V ₊ = 4.5 V, V ₋ = -4.5 V,	25°C	12	20	_
ON-state resistance	r _{on}	$V_{COM} = 3.5 V,$ $I_{COM} = 20 mA$	Full		25	Ω
ON-state resistance		$V_{+} = 4.5 V, V_{-} = -4.5 V,$	25°C	1.2	2.5	0
flatness	r _{on(flat)}	$V_{COM} = -3.5 V, 0 V, 3.5 V,$ $I_{COM} = 20 mA$	Full		3	Ω
NO, NC	I _{NO(OFF)} ,	$V_{+} = 5.5 V, V_{-} = -5.5 V,$	25°C		5	~ ^
OFF leakage current ⁽³⁾	I _{NC(OFF)}	$V_{COM} = 4.5 \text{ V},$ $V_{NO} \text{ or } V_{NC} = -4.5 \text{ V}$	Full		10	nA
СОМ		$V_{+} = 5.5 V, V_{-} = -5.5 V,$	25°C		5	0
OFF leakage current ⁽³⁾	ICOM(OFF)	$V_{COM} = -4.5 \text{ V},$ $V_{NO} \text{ or } V_{NC} = 4.5 \text{ V}$	Full		10	nA
СОМ		$V_{+} = 5.5 V, V_{-} = -5.5 V,$	25°C		5	
ON leakage current ⁽³⁾	I _{COM(ON)}	$V_{COM} = 5.5 V,$ $V_{NO} \text{ or } V_{NC} = \text{open}$	Full		10	nA
Digital Control Input (IN)	-					
Input logic high	V _{IH}		Full	V ₊ – 1.5		V
Input logic low	V _{IL}		Full	V_	$V_{+} - 3.5$	V
Input leakage current	I _{IH} , I _{IL}	$V_{IN} = V_+, 0 V$	Full		0.010	μA
Dynamic						
Turn-on time	tou	See Figure 2	25°C	58	75	ns
Tum-on time	t _{ON}	See Figure 2	Full		85	
Turn-off time	torr	See Figure 2	25°C	28	45	ns
	t _{OFF}		Full		50	
Charge injection ⁽⁴⁾	Q _C	$\begin{array}{l} C_L = 1 \text{ nF}, V_{NO} = 0 \text{ V}, \\ R_S = 0 \Omega, \text{ See Figure 1} \end{array}$	25°C	-13		рС
NO, NC OFF capacitance	C _{NO(OFF)} , C _{NC(OFF)}	f = 1 MHz, See Figure 4	25°C	5.5		pF
COM OFF capacitance	C _{COM(OFF)}	f = 1 MHz, See Figure 4	25°C	5.5		pF
COM ON capacitance	C _{COM(ON)}	f = 1 MHz, See Figure 4	25°C	16		pF
Digital input capacitance	Cl	V _{IN} = V ₊ , 0 V	25°C	1.5		pF
Bandwidth	BW	$R_L = 50 \Omega, C_L = 15 pF,$ V _{NO} = 1 V _{RMS} , f = 100 kHz	25°C	464		MHz
OFF isolation	O _{ISO}	$R_{L} = 50 \Omega, C_{L} = 15 \text{ pF},$ $V_{NO} = 1 V_{RMS}, f = 1 \text{ MHz}$	25°C	-83		dB
Total harmonic distortion	THD	$R_{L} = 600 \Omega, C_{L} = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 20 kHz$	25°C	0.07		%
Supply	<u> </u>		1			
			25°C		70	
V ₊ supply current	I+	$V_{IN} = 0 V \text{ or } V_+$	Full		80	μA
			25°C	-70		
V_ supply current	t I_ N	$V_{IN} = 0 V \text{ or } V_+$	Full	-80		μA

(1) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.

Typical values are at $T_A = 25^{\circ}C$. (2)

(3) (4) Leakage parameters are 100% tested at maximum-rated hot operating temperature, and are ensured by correlation at 25°C.

Specified by design, not production tested

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Electrical Characteristics for ±3.3-V Supply⁽¹⁾

 V_{+} = 3.0 V to 3.6 V, V_{-} = –3.0 V to –3.6, T_{A} = –40°C to 85°C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	T _A	MIN	TYP ⁽²⁾	MAX	UNIT	
Analog Switch								
Analog signal range	V _{COM} , V _{NO} , V _{NC}			V_		V ₊	V	
		V ₊ = 3.0 V, V ₋ = -3.0 V,	25°C		17	25		
ON-state resistance	r _{on}	$V_{COM} = 3 V,$ $I_{COM} = 20 mA$	Full			35	Ω	
ON-state resistance	r	$V_{COM} = -2 V, 0 V, 2 V,$	25°C		1.5	3	Ω	
flatness	r _{on(flat)}	$I_{COM} = 20 \text{ mA}$	Full			4	12	
NO, NC	I _{NO(OFF),}	$V_{+} = 3.6 V, V_{-} = -3.6 V,$	25°C			5		
OFF leakage current ⁽³⁾	I _{NC(OFF)}	$V_{COM} = 3 V,$ $V_{NO} \text{ or } V_{NC} = -3 V$	Full			10	nA	
СОМ		$V_{+} = 3.6 V, V_{-} = -3.6 V,$	25°C			5	0	
OFF leakage current ⁽³⁾	I _{COM(OFF)}	$V_{COM} = -3 V,$ $V_{NO} \text{ or } V_{NC} = 3 V$	Full			10	nA	
СОМ		$V_{+} = 3.6 V, V_{-} = -3.6 V,$	25°C			5		
ON leakage current ⁽³⁾	I _{COM} (ON)	$V_{COM} = 3.6 V,$ $V_{NO} \text{ or } V_{NC} = \text{open}$	Full			10	nA	
Digital Control Input (IN)								
Input logic high	V _{IH}		Full	V ₊ – 1.5			V	
Input logic low	V _{IL}		Full	V_		$V_{+} - 3.5$	V	
Input leakage current	I _{IH} , I _{IL}	$V_{IN} = V_+, 0 V$	Full			0.01	μA	
Dynamic								
Turn-on time	+	soo Figuro 2	25°C		65	85	nc	
	t _{ON}	see Figure 2	Full			95	ns	
Turn-off time	+	ano Figuro 2	25°C		37	60	ns	
rum-on time	tOFF	see Figure 2	Full			70		
Charge injection ⁽⁴⁾	Q _C	$\begin{array}{l} C_L = 1 \text{ nF}, V_{NO} = 0 \text{ V}, \\ R_S = 0 \Omega, \text{ See Figure 1} \end{array}$	25°C		-7.5		рС	
NO, NC OFF capacitance	$C_{NO(OFF)} \ C_{NC(OFF)}$	f = 1 MHz, See Figure 4	25°C		5.5		pF	
COM OFF capacitance	C _{COM(OFF)}	f = 1 MHz, See Figure 4	25°C		5.5		pF	
COM ON capacitance	C _{COM(ON)}	f = 1 MHz, See Figure 4	25°C		16		pF	
Digital input capacitance	CI	$V_{IN} = V_+, 0 V$	25°C		1.5		pF	
Bandwidth	BW	$R_L = 50 \Omega, C_L = 15 pF,$ $V_{NO} = 1 V_{RMS}, f = 100 kHz$	25°C		464		MHz	
OFF isolation	O _{ISO}	$ \begin{array}{l} {\sf R}_{\sf L} = 50 \ \Omega, \ {\sf C}_{\sf L} = 15 \ {\sf pF}, \\ {\sf V}_{\sf NO} = 1 \ {\sf V}_{\sf RMS}, \ {\sf f} = 100 \ {\sf kHz} \end{array} $	25°C		-83		dB	
Total harmonic distortion	THD		25°C		0.10		%	
Supply								
			25°C			40	u A	
V ₊ supply current	I ₊	$V_{IN} = 0 V \text{ or } V_+$	Full			45		
			25°C	-40				
V_ supply current	I_	$V_{IN} = 0 V \text{ or } V_+$	Full	45			μA	

(1) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.

Typical values are at $T_A = 25^{\circ}C$. (2)

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(3) Leakage parameters are 100% tested at maximum-rated hot operating temperature, and are ensured by correlation at 25°C.
 (4) Specified by design, not production tested



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Electrical Characteristics for ±1.8-V Supply⁽¹⁾

V₊ = 1.65 V to 1.95 V, V₋ = -1.65 V to -1.95 V, T_A = -40° C to 85° C (unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS	TA	MIN	TYP ⁽²⁾	MAX	UNIT	
Analog Switch			Ļ			1		
Analog signal range	V _{COM} , V _{NO} , V _{NC}			V_		V ₊	V	
		V ₊ = 1.65 V, V ₋ = -1.65 V,	25°C		28	40		
ON-state resistance	r _{on}	$V_{COM} = 0 V,$ $I_{COM} = 20 mA$	Full			47	Ω	
ON-state resistance		V ₊ = 1.65 V, V ₋ = -1.65 V,	25°C		9	13	•	
flatness	r _{on(flat)}	V _{COM} = -1.8 V, 0 V, 1.5 V, I _{COM} = 20 mA	Full			15	Ω	
NO, NC	I _{NO(OFF)}	V ₊ = 1.95 V, V ₋ = -1.95 V,	25°C			5		
OFF leakage current ⁽³⁾	I _{NC(OFF)}	$V_{COM} = 1.65 \text{ V},$ $V_{NO} \text{ or } V_{NC} = -1.65 \text{ V}$	Full			10	nA	
СОМ		V ₊ = 1.95 V, V ₋ = -1.95 V,	25°C			5		
OFF leakage current ⁽³⁾	ICOM(OFF)	$V_{COM} = -1.65 \text{ V},$ $V_{NO} \text{ or } V_{NC} = 1.65 \text{ V}$	Full			10	nA	
СОМ		V ₊ = 1.95 V, V ₋ = -1.95 V,	25°C			5	_	
ON leakage current ⁽³⁾	I _{COM(ON)}	$V_{COM} = 1.95 V,$ $V_{NO} \text{ or } V_{NC} = \text{ open}$	Full			10	nA	
Digital Control Input (IN)								
Input logic high	V _{IH}		Full	V ₊ – 1.5			V	
Input logic low	V _{IL}		Full	V_		V ₊ – 3.5	V	
Input leakage current	I _{IH} , I _{IL}	$V_{IN} = V_+, 0 V$	Full			0.01	μA	
Dynamic								
Turn-on time ⁽⁴⁾	+	See Figure 2	25°C		90	120	20	
	t _{ON}	See Figure 2	Full			150	ns	
Turn-off time ⁽⁴⁾	+	Soo Figuro 2	25°C		95	150	200	
	t _{OFF}	See Figure 2	Full			200	ns	
Charge injection ⁽⁴⁾	Q _C	C _L = 1 nF, See Figure 1	25°C		-3.5		рС	
NO, NC OFF capacitance	$C_{NO(OFF)}, C_{NC(OFF)}$	f = 1 MHz, See Figure 4	25°C		6		pF	
COM OFF capacitance	C _{COM(OFF)}	f = 1 MHz, See Figure 4	25°C		6		pF	
COM ON capacitance	C _{COM(ON)}	f = 1 MHz, See Figure 4	25°C		14.5		pF	
Digital input capacitance	CI	$V_{IN} = V_+, 0 V$	25°C		1.5		pF	
Bandwidth	BW	$R_L = 50 \Omega, C_L = 15 pF,$ V _{NO} = 1 V _{RMS} , f = 100 kHz	25°C		464		MHz	
OFF isolation	O _{ISO}	$\begin{aligned} R_{L} &= 50 \ \Omega, \ C_{L} &= 15 \ pF, \\ V_{NO} &= 1 \ V_{RMS}, \ f &= 1 \ MHz \end{aligned}$	25°C		-83		dB	
Total harmonic distortion	THD	$ \begin{array}{l} R_{L} = 600 \; \Omega, C_{L} = 50 \; pF, \\ V_{NO} = 1 \; V_{RMS}, f = 20 \; kHz \end{array} $	25°C		0.37		%	
Supply								
	ı		25°C			20		
V ₊ supply current	I+	$V_{IN} = 0 V \text{ or } V_+$	Full			30	μA	
Manager and the second second			25°C	-20				
V_ supply current	I_	$V_{IN} = 0 V \text{ or } V_+$	Full	-30			μΑ	

The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum. (1)

(2) Typical values are at $T_A = 25^{\circ}C$.

(2) (3) (4) Leakage parameters are 100% tested at maximum-rated hot operating temperature, and are ensured by correlation at 25°C.

Specified by design, not production tested

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PIN DESCRIPTION⁽¹⁾

	PIN	I NO.					
TS12	TS12A4516		2A4517	NAME	DESCRIPTION		
D, P	SOT23-5	D, P	SOT23-5	-			
1	1	1	1	COM	Common		
2, 3, 5	-	2, 3, 5	-	N.C.	No connect (not internally connected)		
4	5	4	5	V ₊	Positive power supply		
6	4	6	4	IN	Digital control to connect COM to NO or NC		
7	3	7	3	V_	Negative power supply		
8	2	-	-	NO	Normally open		
-	-	8	2	NC	Normally closed		

(1) NO, NC, and COM pins are identical and interchangeable. Any may be considered as an input or an output; signals pass in both directions.

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TEXAS INSTRUMENTS

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APPLICATION INFORMATION

Power-Supply Considerations

The TS12A4516 and TS12A4517 operate with power-supply voltages from ± 1 V to ± 6 V [(2 V < (V₊ - V₋) < 12 V], but are tested and specified at ± 5 V, ± 3.3 V, and ± 1.8 V supplies. The pin-compatible TS12A4514 and TS12A4515 are recommended for use when only a single supply is desirable.

The TS12A4516 and TS12A4517 construction is typical of most CMOS analog switches, except that they have only two supply pins: V_+ and V_- . V_+ and V_- drive the internal CMOS switches and set their analog voltage limits. Reverse ESD-protection diodes are internally connected between each analog-signal pin and both V_+ and V_- . One of these diodes conducts if any analog signal exceeds V_+ or V_- .

Virtually all the analog leakage current comes from the ESD diodes to V_+ or V_- . Although the ESD diodes on a given signal pin are identical and, therefore, fairly well balanced, they are reverse biased differently. Each is biased by either V_+ or V_- and the analog signal. This means their leakages will vary as the signal varies. The difference in the two diode leakages to the V_+ and V_- pins constitutes the analog-signal-path leakage current. All analog leakage current flows between each pin and one of the supply terminals, not to the other switch terminal. This is why both sides of a given switch can show leakage currents of the same or opposite polarity.

 V_+ and V_- also power the internal logic and logic-level translators. The logic-level translators convert the logic levels to switched V_+ and V_- signals to drive the analog signal gates.

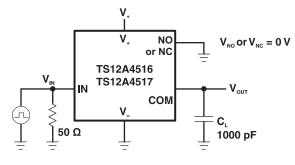
Logic-Level Thresholds

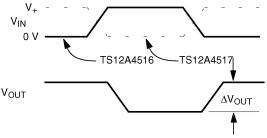
Since these parts have no ground pin, the logic-level threshold is referenced to V₊. The threshold limits are V₊ -1.5 V and V₊ -3.5 V for V₊ levels between 6 V and 3 V. When V₊ = 2 V, the logic threshold is approximately 0.6 V.

CAUTION:

Do not connect the TS12A4516/TS12A4517 V₊ to 3 V and then connect the logic-level pins to logic-level signals that operate from 5-V supply. TTL levels can exceed 3 V and violate the absolute maximum ratings, damaging the part and/or external circuits.

Test Circuits/Timing Diagrams





 ΔV_{OUT} is the measured voltage due to charge transfer error Q when the channel turns off.

 $Q = \Delta V_{OUT} \times C_L$

Figure 1. Charge Injection

TS12A4516, TS12A4517



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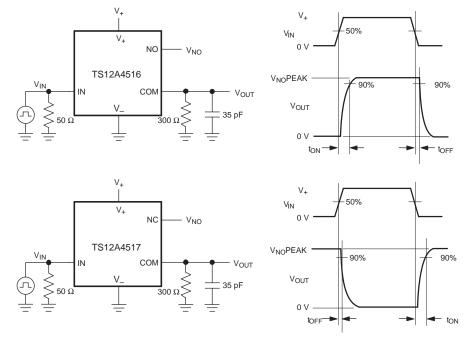
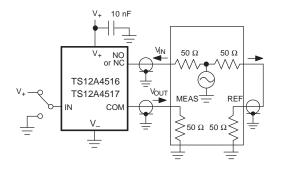
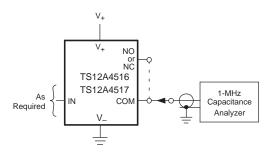


Figure 2. Switching Times



Measurements are standardized against short at socket terminals. OFF isolation is measured between COM and OFF terminals on each switch. ON loss is measured between COM and ON terminals on each switch. Signal direction through switch is reversed; worst values are recorded. OFF location = 20log $\frac{V_{OUT}}{V_{IN}}$ ON Loss = 20log $\frac{V_{OUT}}{V_{IN}}$







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10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TS12A4516D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD516	Samples
TS12A4516DBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(9CLA ~ 9CLM)	Samples
TS12A4516DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD516	Samples
TS12A4516DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD516	Samples
TS12A4517D	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD517	Samples
TS12A4517DBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	(9CMA ~ 9CMM)	Samples
TS12A4517DG4	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD517	Samples
TS12A4517DR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD517	Samples
TS12A4517DRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	YD517	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)



PACKAGE OPTION ADDENDUM

10-Jun-2014

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

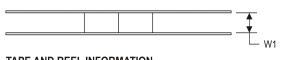
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE AND REEL INFORMATION

TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

	*All dimensions are nominal		
1			

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS12A4516DBVR	SOT-23	DBV	5	3000	180.0	8.4	3.23	3.17	1.37	4.0	8.0	Q3
TS12A4516DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TS12A4517DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS12A4516DBVR	SOT-23	DBV	5	3000	202.0	201.0	28.0
TS12A4516DR	SOIC	D	8	2500	367.0	367.0	35.0
TS12A4517DR	SOIC	D	8	2500	367.0	367.0	35.0

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



- All linear dimensions are in millimeters. A.
 - This drawing is subject to change without notice. Β.
 - Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side. C.
 - D. Falls within JEDEC MO-178 Variation AA.



DBV (R-PDSO-G5)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.

- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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